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Notic of References Cit d

Application/C ntrol N	Applicant(s)/Patent Und r Reexamination
08/897,455	STACHE ET AL.
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	Dage 1 of 1

<u></u>	Barbara P Badio, Ph.D. 1616					l ago .					
*	U.S. PATENT DOCUMENTS DOCUMENT										
*		DOCUMENT NO.	DATE	NAME		CLASS	SUBCLASS	SOURCE APS	OTHER		
	Α	3,133,940	May. 1964	Oughton et al.		260	397.45	×			
	В	3,201,391	Aug. 1965	Bowers		260	239.55	⊠			
	C	3,201,429	Aug. 1965	Djerassi et al.		260	397.47	⊠			
×	D	4,655,971	Apr. 1987	Page et al.		260	397.45	⊠			
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*A copy of this reference is not being furnished with this Office action. (See Manual of Patent Examining Procedure, Section 707.05(a).)
**APS encompasses any electronic search i.e. text, image, and Commercial Databases.
U.S. Patent and Trademark Office
PTO-892 (Rev. 03-98)

N tice f References Cited